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| Notice of References Cited | Application/Control No. 10/076,670 | Applicant(s)/Patent Under Reexamination LESIEUR ET AL. | |
| | Examiner Tam M. Nguyen | Art Unit 1764 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|--|-----------------|----------------------|----------------|
| A | US-6,348,075 | 02-2002 | Jackson, Mitchell M. | 44/432 |
| B | US-6,454,935 | 09-2002 | Lesieur et al. | 208/244 |
| C | US-6,533,924 | 03-2003 | Lesieur et al. | 208/244 |
| D | US-3,485,746 | 12-1969 | Setzer et. al. | 208/244 |
| E | US- | | | |
| F | US- | | | |
| G | US- | | | |
| H | US- | | | |
| I | US- | | | |
| J | US- | | | |
| K | US- | | | |
| L | US- | | | |
| M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|--|-----------------|---------|------|----------------|
| N | | | | | |
| O | | | | | |
| P | | | | | |
| Q | | | | | |
| R | | | | | |
| S | | | | | |
| T | | | | | |

NON-PATENT DOCUMENTS

| | | | |
|---|---|--|--|
| * | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | |
| U | | | |
| V | | | |
| W | | | |
| X | | | |

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